

<b>Notice of References Cited</b>	Application/Control No. 10/715,599	Applicant(s)/Patent Under Reexamination SLOTKIN ET AL	
	Examiner Uyen-Chau N. Le	Art Unit 2876	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,764,736	06-1998	Shachar et al.	379/93.09
	B	US-6,175,741	01-2001	Alperovich, Vladimir	455/458
	C	US-6,240,302	05-2001	Harrison, Dana C.	455/556.1
	D	US-6,254,001	07-2001	Chan, George Ming Fai	235/380
	E	US-6,533,171	03-2003	Porter, Lawrence Leon	235/380
	F	US-6,601,111	07-2003	Peacock et al.	719/310
	G	US-6,633,311	10-2003	Douvikas et al.	715/731
	H	US-6,771,290	08-2004	Hoyle, Martin David	715/745
	I	US-6,873,861	03-2005	Awada et al.	455/566
	J	US-6,883,000	04-2005	Gropper, Robert L.	707/10
	K	US-2002/0023952	02-2002	Sakanashi et al.	235/380
	L	US-5,640,565	06-1997	Dickinson, Robert David	707/103R
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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